- Inverting Versions of SN54LS153, SN74LS153
- Schottky-Diode-Clamped Transistors
- Permits Multiplexing from N lines to 1 line
- Performs Parallel-to-Serial Conversion
- Typical Average Propagation Delay Times:
 Data Input to Output . . . 15 ns
 Strobe Input to Output . . . 19 ns
 Select Input to Output . . . 22 ns
- Fully Compatible with most TTL Circuits
- Low Power Dissipation . . . 31 mW Typical (Enabled)

description

Each of these Schottky-clamped data selectors/-multiplexers contains inverters and drivers to supply fully complementary, on-chip, binary decoding data selection to the AND-OR-invert gates. Separate strobe inputs are provided for each of the two four-line sections.

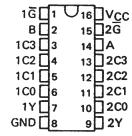
FUNCTION TABLE

SELECT		Ι.		0.00 IT	070005			
INP	UTS	١ '	JAIAI	NPUT:	STROBE	OUTPUT		
В	Α	CO	C1 C2 C3		G	Υ		
х	X	X	X	X	X	Н	Н	
L	L	L	X	Х	X	L	н	
L	L	н	X	X	X	į.	L	
L	Н	×	L	Х	X	L	н	
L	Н	x	Н	X	Х	L.	L	
н	L	×	X	L	Х	L	н	
н	L	x	X	н	X	L	L	
н	Н	X	X	X	L	L	н	
н	н	×	×	х	Ĥ	Ł	l L	

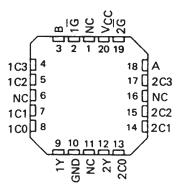
Select inputs A and B are common to both sections.

H = high level, L = low level, X = irrelevant

SN54LS352 . . . J OR W PACKAGE SN74LS352 . . . D OR N PACKAGE (TOP VIEW)

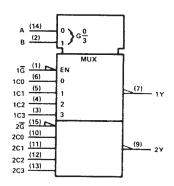


SN54LS352 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic symbol[†]



 $^{^\}dagger \text{This}$ symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

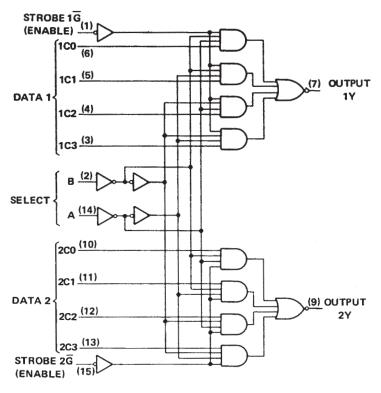
absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see No	te 1)		 		 			7 V
Input voltage		 	 					7 V
Operating free-air temperatu	re range: SN54LS352		 					-55°C to 125°C
								. 0°C to 70°C
Storage temperature range			 					65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.

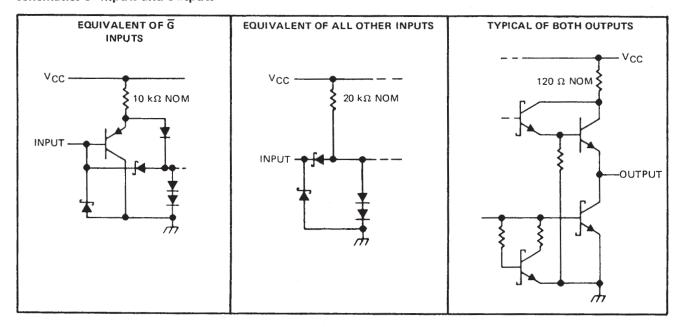


logic diagram (positive logic)



Pin numbers shown are for D, J, N, and W packages.

schematics of inputs and outputs





recommended operating conditions

		S	SN54LS352			SN74LS352			
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
Vcc	Supply voltage	4.5	5	5.5	4.75	5	5.25	٧	
VIH	High-level input voltage	2			2			V	
VIL	Low-level input voltage			0.7			0.8	V	
I _{OH}	High-level output current			- 0.4			- 0.4	mA	
IOL	Low-level output current			4			8	mA	
T_A	Operating free-air temperature	– 55		125	0		70	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS [†]	SN54LS352	SN74LS352	
FARAMETER	TEST CONDITIONS.	MIN TYP# MAX	MIN TYP# MAX	UNIT
VIK	V _{CC} = MIN, I _I = -18 mA	- 1.5	- 1.5	V
Voн	$V_{CC} = MIN$, $V_{IH} = 2V$, $V_{IL} = MAX$, $I_{OH} = -0.4 \text{ mA}$	2.5 3.4	2.7 3.4	V
VOL	V _{CC} = MIN, V _{1H} = 2 V, I _{OL} = 4 mA V _{IL} = MAX I _{OL} = 8 mA	0.25 0.4	0.25 0.4 0.35 0.5	٧
tı	V _{CC} = MAX, V _I = 7 V	0.1	0.1	mA
ΊΗ	V _{CC} = MAX, V _I = 2.7 V	20	20	μΑ
IIL G All other	V _{CC} = MAX, V ₁ = 0.4 V	- 0.2 - 0.4	- 0.2 - 0.4	mA
los§	V _{CC} = MAX	- 20 - 100	- 20 - 100	mA
ICCL	V _{CC} = MAX, See Note 2	6.2 10	6.2 10	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST COM	MIN	TYP	MAX	UNIT	
tPLH	Data	Y				13	20	ns
^t PHL	Data	Υ				17	26	ns
^t PLH	A or B	Υ	$R_L = 2 k\Omega$, See Note 3	C _L = 15 pF,		19	29	ns
^t PHL	A or B	Υ				25	38	ns
^t PLH	G	Υ				16	24	ns
^t PHL	Ğ	Y				21	32	ns

¹ tpLH = propagation delay time, low-to-high-level output

 $^{^{\}ddagger}$ All typical values are at $V_{CC} = 5 \text{ V}$, $T_{A} = 25 \,^{\circ}\text{C}$.

[§] Not more than one output should be shorted at a time, and duration of the short-circuit should not exceed one second. NOTE 2: ICCL is measured with the outputs open and all inputs grounded.

tpHL = propagation delay time, high-to-low-level output

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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